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Study of processes of reverse intersystem crossing (RISC) and thermally activated delayed fluorescence (TADF) in organic light emitting diodes (OLEDs)

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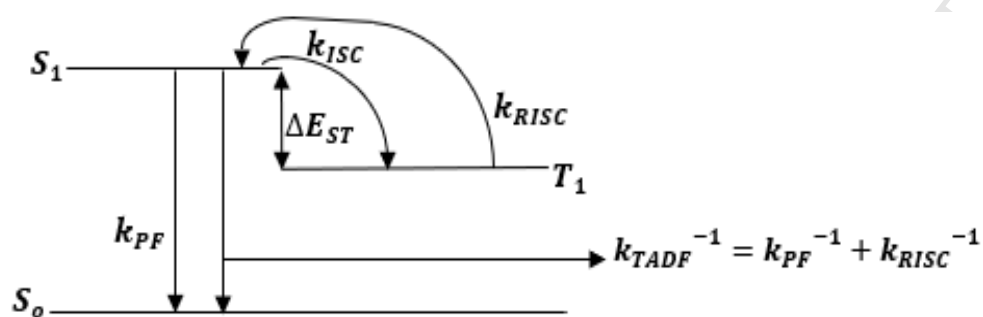
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## Graphical Abstract



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